

# AP6679GS-A-VB Datasheet P-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	-40				
$R_{DS(on)}$ ( $\Omega$ ) at $V_{GS}$ = -10 V	0.012				
$R_{DS(on)}\left(\Omega\right)$ at $V_{GS}$ = -4.5 V	0.015				
I <sub>D</sub> (A)	-60				
Configuration	Single				

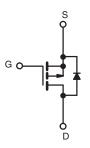
## FEATURES

- TrenchFET<sup>®</sup> power MOSFET
- Package with low thermal resistance
- + 100 %  $\rm R_g$  and UIS tested









P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T	$_{\rm C} = 25 ^{\circ}{\rm C}$ , unles	s otherwise noted	l)		
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V <sub>DS</sub>	-40	N/	
Gate-Source Voltage	V <sub>GS</sub>	± 20	V		
Continuous Drain Current	T <sub>C</sub> = 25 °C <sup>a</sup>	1	-60		
Continuous Drain Current	T <sub>C</sub> = 125 °C	Ι <sub>D</sub>	-45		
Continuous Source Current (Diode Conduction) <sup>a</sup>		I <sub>S</sub>	-60	А	
Pulsed Drain Current <sup>b</sup>		I <sub>DM</sub>	-230		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	-45		
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	80	mJ	
	T <sub>A</sub> = 25 °C		3.5		
Maximum Power Dissipation <sup>b</sup>	T <sub>C</sub> = 25 °C	PD	166	W	
	T <sub>C</sub> = 125 °C		65		
Operating Junction and Storage Temperature Ra	TJ, T <sub>stg</sub>	-55 to +175	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT	UNIT		
Junction-to-Ambient	PCB Mount <sup>c</sup>	R <sub>thJA</sub>	50	°C/W		
Junction-to-Case (Drain)		R <sub>thJC</sub>	1.1	0/10		

#### Notes

a. Package limited.

b. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

c. When mounted on 1" square PCB (FR4 material).

d. Parametric verification ongoing.

<b>SPECIFICATIONS</b> ( $T_C = 25 \degree C$		1					
PARAMETER	SYMBOL	TES	ST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static		- 1			T	0	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = -250 μA	-40	-	-	v
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$		-	-2.5	, i
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>DS</sub> =	$V_{DS}=0~V,~V_{GS}=\pm~20~V$		-	± 100	nA
		$V_{GS} = 0 V$	V <sub>DS</sub> = -40 V	-	-	-1	μA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	$V_{DS}$ = -40 V, T <sub>J</sub> = 125 °C	-	-	-50	
		$V_{GS} = 0 V$	$V_{DS}$ = -40 V, T <sub>J</sub> = 175 °C	-	-	-150	
On-State Drain Currenta	I <sub>D(on)</sub>	$V_{GS} = -10 V$	$V_{DS} \le -5 V$	-60	-	-	А
		$V_{GS} = -10 V$	I <sub>D</sub> = -17 A	-	0.012	-	Ω
Drain-Source On-State Resistance <sup>a</sup>	В	$V_{GS} = -10 \text{ V}$	I <sub>D</sub> = -50 A, T <sub>J</sub> = 125 °C	-	0.017	-	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = -10 V$	l <sub>D</sub> = -50 A, T <sub>J</sub> = 175 °C	-	0.020	-	
		V <sub>GS</sub> = -4.5 V	I <sub>D</sub> = -14 A	-	0.015	-	
Forward Transconductance <sup>a</sup>	<b>g</b> fs	V <sub>DS</sub> =	V <sub>DS</sub> = -15 V, I <sub>D</sub> = -17 A		61	-	S
Dynamic <sup>b</sup>						•	
Input Capacitance	C <sub>iss</sub>			-	2872	3950	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 V$	$V_{\rm GS} = 0 \ {\rm V}$ $V_{\rm DS} = -25 \ {\rm V}, \ {\rm f} = 1 \ {\rm MHz}$	-	508	635	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			-	352	440	
Total Gate Charge <sup>c</sup>	Qg			-	60	80	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	V <sub>GS</sub> = -10 V	$V_{DS} = -30 \text{ V}, I_D = -50 \text{ A}$	-	5.7	8.6	nC
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>				14.7	22	1
Gate Resistance	Rg	f = 1 MHz		1.5	3	4.5	Ω
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			-	10	15	
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD}$ = -20 V, R <sub>L</sub> = 0.4 $\Omega$ I <sub>D</sub> $\cong$ -50 A, V <sub>GEN</sub> = -10 V, R <sub>g</sub> = 1 $\Omega$		-	12	18	- ns
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>			-	40	60	
Fall Time <sup>c</sup>	t <sub>f</sub>			-	16	24	
Source-Drain Diode Ratings and Char	acteristics <sup>b</sup>						
Pulsed Current <sup>a</sup>	I <sub>SM</sub>			-	-	-200	Α
Forward Voltage	V <sub>SD</sub>	I <sub>F</sub> = -50 A, V <sub>GS</sub> = 0 V		-	-1	-1.5	V
	1	1				I	I

#### Notes

a. Pulse test; pulse width  $\leq 300~\mu\text{s},~\text{duty}~\text{cycle} \leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

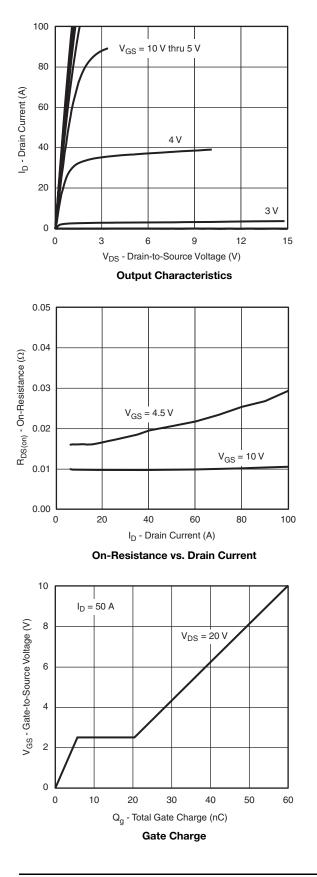
c. Independent of operating temperature.

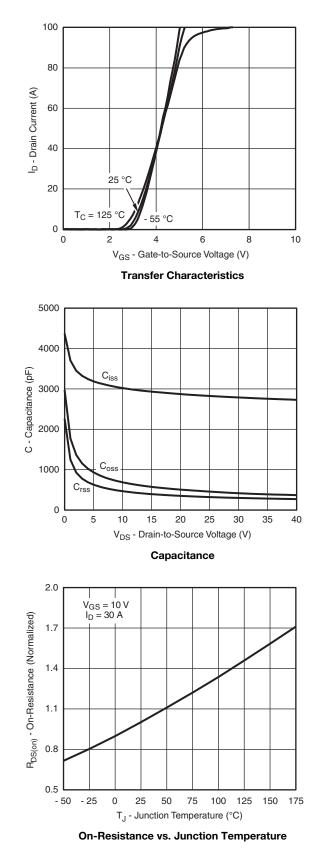
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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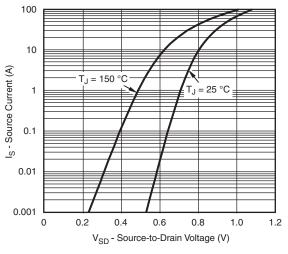
## **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



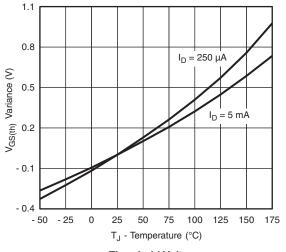




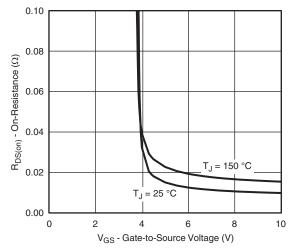
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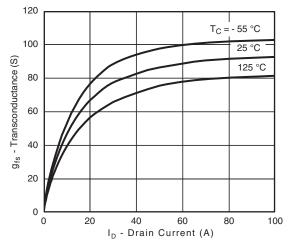
Source Drain Diode Forward Voltage



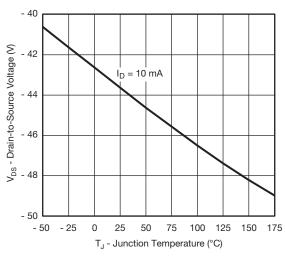


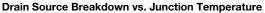


**On-Resistance vs. Gate-to Source Voltage** 



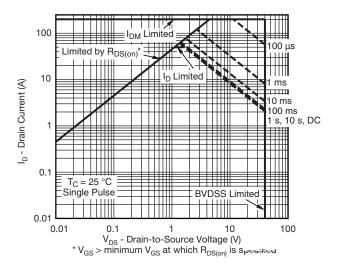




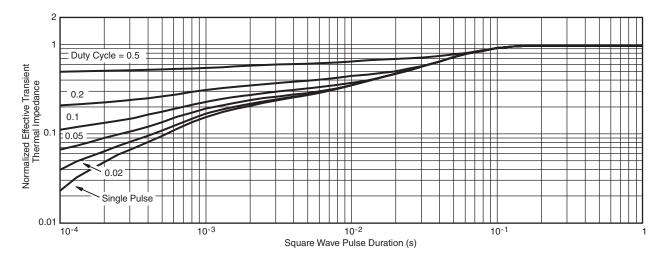




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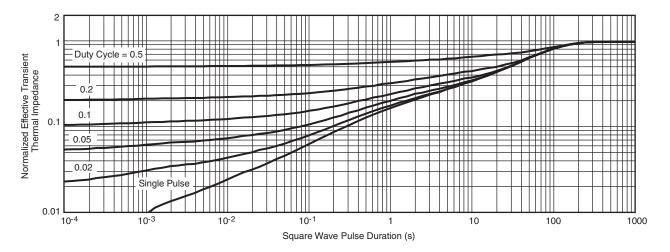


Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Case





#### Normalized Thermal Transient Impedance, Junction-to-Ambient

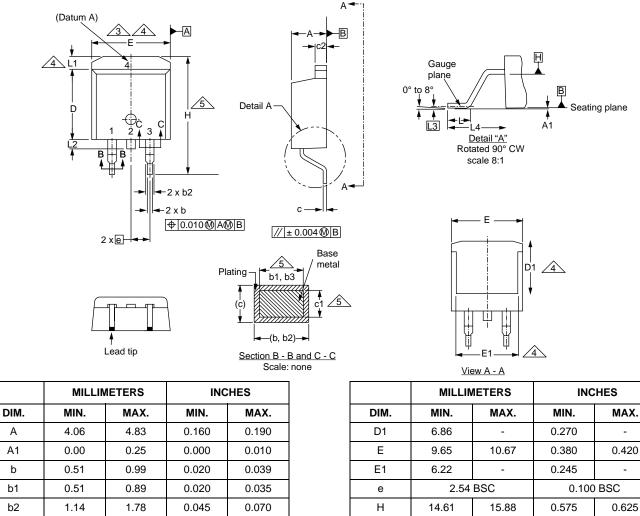
#### Note

- The characteristics shown in the two graphs
  - Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
  - Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



## **TO-263AB (HIGH VOLTAGE)**



D	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

ECN: S-82110-Rev. A, 15-Sep-08 DWG: 5970

#### Notes

А

A1

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1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimensions are shown in millimeters (inches).

3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.

L

L1

L2

L3 L4

1.78

-

-

4.78

4. Thermal PAD contour optional within dimension E, L1, D1 and E1.

5. Dimension b1 and c1 apply to base metal only.

6. Datum A and B to be determined at datum plane H.

7. Outline conforms to JEDEC outline to TO-263AB.

2.79

1.65

1.78

5.28

0.25 BSC

0.070

-

-

0.188

0.010 BSC

0.110

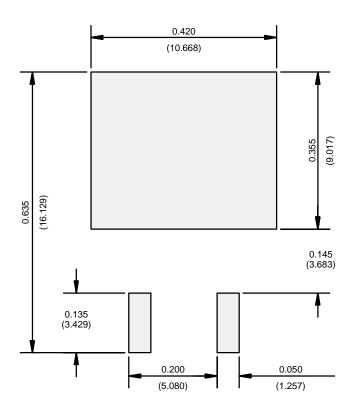
0.066

0.070

0.208



## **RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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